

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/895,353	AVERY ET AL.	
Examiner		Art Unit	Shin-Hon Chen	
		2131	Page 1 of 1	

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	B	US-6,477,434	11-2002	Wewalaarachchi et al.	700/83
	C	US-6,591,242	07-2003	Karp et al.	705/2
	D	US-6,370,582	04-2002	Lim et al.	709/230
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	L	US-			
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**NON-PATENT DOCUMENTS**

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